

<b>Notice of References Cited</b>	Application/Control No. 10/604,594		Applicant(s)/Patent Under Reexamination HIROYUKI AKATSU	
	Examiner Khiem D Nguyen		Art Unit 2823	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,426,254	07-2002	Kudelka et al.	438/246
*	B	US-6,660,582	12-2003	Birner et al.	438/245
*	C	US-2003/0045052	03-2003	Birner et al.	438/243
*	D	US-6,767,786	07-2004	Lin et al.	438/243
*	E	US-2003/0194867	10-2003	Kudelka et al.	438/689
*	F	US-6,599,798	07-2003	Tews et al.	438/249
*	G	US-6,190,988	02-2001	Furukawa et al.	438/386
*	H	US-6,180,480	01-2001	Economikos et al.	438/386
*	I	US-5,930,107	07-1999	Rajeevakumar, Thekkemadathil Velayudhan	361/321.4
	J	US-			438/249
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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